Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/003,720	DEW ET AL.
Examiner	Art Unit
Chris Parry	2614

	SEARCHED				
Class	Subclass	Date	Examiner		
725	37-39	12/2/2005	CLP		
725	46	12/2/2005	CLP		
725	85	12/2/2005	CLP		
725	78	12/2/2005	CLP		
725	13	12/2/2005	CLP		

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
See attached search strategy from EAST (USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB).	12/7/2005	CLP
Consulted Scott Beliveau on areas of search in class 725.	12/5/2005	CLP